





RADIO TEST REPORT

Test Report No.: 14862950H-A-R2

| | |
|---------------------|-----------------------|
| Customer | Keyence Corporation |
| Description of EUT | Level sensor |
| Model Number of EUT | FR-S01 |
| FCC ID | RF41754A |
| Test Regulation | FCC Part 15 Subpart C |
| Test Result | Complied |
| Issue Date | September 28, 2023 |
| Remarks | - |

| | |
|--|--|
| Representative test engineer | Approved by |
|  |  |
| Sayaka Hara Engineer | Ryota Yamanaka Engineer |
|   | |
| CERTIFICATE 5107.02 | |
| <input type="checkbox"/> The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan, Inc. <input checked="" type="checkbox"/> There is no testing item of "Non-accreditation". | |

Report Cover Page - Form-ULID-003532 (DCS:13-EM-F0429) Issue# 22.0

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- The information provided from the customer for this report is identified in Section 1.
- For test report(s) referred in this report, the latest version (including any revisions) is always referred.

REVISION HISTORY

Original Test Report No.: 14862950H-A

This report is a revised version of 14862950H-A-R1. 14862950H-A-R1 is replaced with this report.

| Revision | Test Report No. | Date | Page Revised Contents |
|-----------------|-----------------|-----------------------|---|
| - (Original) | 14862950H-A | September 22, 2023 | - |
| 1 | 14862950H-A-R1 | September 26, 2023 | Correction of the note *1) in Clause 3.2. |
| 1 | 14862950H-A-R1 | September 26, 2023 | Correction of the Remarks in -20 dBc Frequency Result (Reference) table for Frequency Stability test; from "85 % of the minimum operating voltage, DC 12 V* 0.85" to "85 % of the rated voltage, DC 24 V* 0.85" from "115 % of the maximum operating voltage, DC 12 V* 1.15" to "115 % of the rated voltage, DC 24 V* 1.15" (page: 29, 32, 35, 38, 41) |
| 1 | 14862950H-A-R1 | September 26, 2023 | Correction of the Last Calibration Date for MCH-04 in APPENDIX 2 |
| 2 | 14862950H-A-R2 | September 28, 2023 | Re-modification of the note *1) in Clause 3.2. |
| 2 | 14862950H-A-R2 | September 28, 2023 | Correction of the calculation formula for Duty Cycle, Off Time Requirement test. |

Reference: Abbreviations (Including words undescribed in this report)

| | | | |
|----------------|---|---------|---|
| A2LA | The American Association for Laboratory Accreditation | ICES | Interference-Causing Equipment Standard |
| AC | Alternating Current | IEC | International Electrotechnical Commission |
| AFH | Adaptive Frequency Hopping | IEEE | Institute of Electrical and Electronics Engineers |
| AM | Amplitude Modulation | IF | Intermediate Frequency |
| Amp, AMP | Amplifier | ILAC | International Laboratory Accreditation Conference |
| ANSI | American National Standards Institute | ISED | Innovation, Science and Economic Development Canada |
| Ant, ANT | Antenna | ISO | International Organization for Standardization |
| AP | Access Point | JAB | Japan Accreditation Board |
| ASK | Amplitude Shift Keying | LAN | Local Area Network |
| Atten., ATT | Attenuator | LIMS | Laboratory Information Management System |
| AV | Average | MCS | Modulation and Coding Scheme |
| BPSK | Binary Phase-Shift Keying | MRA | Mutual Recognition Arrangement |
| BR | Bluetooth Basic Rate | N/A | Not Applicable |
| BT | Bluetooth | NIST | National Institute of Standards and Technology |
| BT LE | Bluetooth Low Energy | NS | No signal detect. |
| BW | BandWidth | NSA | Normalized Site Attenuation |
| Cal Int | Calibration Interval | NVLAP | National Voluntary Laboratory Accreditation Program |
| CCK | Complementary Code Keying | OBW | Occupied Band Width |
| Ch., CH | Channel | OFDM | Orthogonal Frequency Division Multiplexing |
| CISPR | Comite International Special des Perturbations Radioelectriques | P/M | Power meter |
| CW | Continuous Wave | PCB | Printed Circuit Board |
| DBPSK | Differential BPSK | PER | Packet Error Rate |
| DC | Direct Current | PHY | Physical Layer |
| D-factor | Distance factor | PK | Peak |
| DFS | Dynamic Frequency Selection | PN | Pseudo random Noise |
| DQPSK | Differential QPSK | PRBS | Pseudo-Random Bit Sequence |
| DSSS | Direct Sequence Spread Spectrum | PSD | Power Spectral Density |
| EDR | Enhanced Data Rate | QAM | Quadrature Amplitude Modulation |
| EIRP, e.i.r.p. | Equivalent Isotropically Radiated Power | QP | Quasi-Peak |
| EMC | ElectroMagnetic Compatibility | QPSK | Quadri-Phase Shift Keying |
| EMI | ElectroMagnetic Interference | RBW | Resolution Band Width |
| EN | European Norm | RDS | Radio Data System |
| ERP, e.r.p. | Effective Radiated Power | RE | Radio Equipment |
| EU | European Union | RF | Radio Frequency |
| EUT | Equipment Under Test | RMS | Root Mean Square |
| Fac. | Factor | RSS | Radio Standards Specifications |
| FCC | Federal Communications Commission | Rx | Receiving |
| FHSS | Frequency Hopping Spread Spectrum | SA, S/A | Spectrum Analyzer |
| FM | Frequency Modulation | SG | Signal Generator |
| Freq. | Frequency | SVSWR | Site-Voltage Standing Wave Ratio |
| FSK | Frequency Shift Keying | TR | Test Receiver |
| GFSK | Gaussian Frequency-Shift Keying | Tx | Transmitting |
| GNSS | Global Navigation Satellite System | VBW | Video BandWidth |
| GPS | Global Positioning System | Vert. | Vertical |
| Hori. | Horizontal | WLAN | Wireless LAN |

| CONTENTS | PAGE |
|--|-------------|
| SECTION 1: Customer Information..... | 5 |
| SECTION 2: Equipment Under Test (EUT) | 5 |
| SECTION 3: Test specification, procedures & results | 6 |
| SECTION 4: Operation of EUT during testing..... | 9 |
| SECTION 5: Conducted Emission | 12 |
| SECTION 6: Radiated Emissions | 13 |
| SECTION 7: Frequency Stability | 19 |
| APPENDIX 1: Test data | 20 |
| Conducted Emission | 20 |
| Duty Cycle, Off Time Requirement | 21 |
| 20 dB Bandwidth..... | 22 |
| EIRP(Peak)..... | 24 |
| Spurious Emissions | 26 |
| Frequency Stability | 29 |
| Group Instillation..... | 44 |
| APPENDIX 2: Test instruments..... | 45 |
| APPENDIX 3: Photographs of test setup | 48 |
| Conducted Emission | 48 |
| EIRP | 49 |
| Spurious Emissions | 50 |
| Worst Case Position | 53 |
| Frequency Stability | 54 |

SECTION 1: Customer Information

| | |
|------------------|--|
| Company Name | Keyence Corporation |
| Address | 1-3-14, Higashinakajima Higashiyodogwa-ku, Osaka, 533-8555 Japan |
| Telephone Number | +81-6-6379-1111 |
| Contact Person | Takashi Suzuki |

The information provided from the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment Under Test (EUT)

2.1 Identification of EUT

| | |
|---------------|---|
| Description | Level sensor |
| Model Number | FR-S01 |
| Serial Number | Refer to SECTION 4.2 |
| Condition | Production prototype (Not for Sale: This sample is equivalent to mass-produced items.) |
| Modification | No Modification by the test lab |
| Receipt Date | July 10, 2023 |
| Test Date | July 10 to 27, 2023 |

2.2 Product Description

General Specification

| | |
|-----------------------|-------------------------|
| Rating | DC 24 V |
| Operating temperature | -20 deg. C to 55 deg. C |

Radio Specification

| | |
|------------------------|--------------------------------------|
| Equipment Type | Transceiver |
| Frequency of Operation | 60.5 GHz (Center) (58 GHz to 63 GHz) |
| Bandwidth | 5 GHz |
| Type of Modulation | Frequency modulation (FMCW) |
| Antenna Gain | 18.8 dBi |
| Steerable Antenna | Electrically |
| Usage location | Fixed Field disturbance sensor |

SECTION 3: Test specification, procedures & results

3.1 Test Specification

| | |
|--------------------|--|
| Test Specification | FCC Part 15 Subpart C The latest version on the first day of the testing period |
| Title | FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits. Section 15.255 Operation within the band 57-71 GHz. |

3.2 Procedures and results

| Item | Test Procedure | Specification | Worst margin | Results | Remarks |
|----------------------------------|--|---|---|----------|----------|
| Conducted Emission | FCC: ANSI C63.10-2013, 6. Standard test methods | FCC: Section 15.207 | 22.87 dB, 4.53050 MHz, AV Phase L | Complied | - |
| Duty cycle, Off Time Requirement | FCC: - | FCC: Section FCC 15.255 (c)(2)(iii)(A) | See data. | Complied | Radiated |
| 6dB Bandwidth | FCC: Section 15.255(e) (2) ANSI C63.10 2013, 9. Procedures for testing millimeter-wave systems | FCC: Section 15.255(e) (1) | - | N/A | *1) |
| 20dB Bandwidth | FCC: ANSI C63.10 2013, 6. Standard test methods | FCC: Section 15.215 (c) | See data. | Complied | Radiated |
| EIRP | FCC: ANSI C63.10 2013, 9. Procedures for testing millimeter-wave systems | FCC: Section 15.255 (c)(2)(iii)(A) | See data. | Complied | Radiated |
| Spurious Emissions | FCC: ANSI C63.10 2013, 6. Standard test methods 9. Procedures for testing millimeter-wave systems | FCC: Section 15.255(d) Section 15.209 | 15.5 dB 408.0 MHz, QP, Vertical | Complied | Radiated |
| Frequency Stability | FCC: ANSI C63.10 2013, 9. Procedures for testing millimeter-wave systems | FCC: Section 15.255(f) | See data. | Complied | Radiated |
| Group Installation | FCC: - | FCC: Section 15.255(h) | - | N/A | *2) |

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.
*1) The test is not applicable since the application of Section 15.255(e) is unnecessary due to the application of Section 15.255(c)(2)(iii)(A).
*2) The test is not applicable since there are no external phase-locking inputs in this EUT.

FCC Part 15.31 (e)

This EUT provides the stable voltage constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

No addition, deviation, nor exclusion has been made from standards.

3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Conducted emission

| Using Item | Frequency range | Uncertainty (+/-) |
|------------|-----------------------|-------------------|
| AMN (LISN) | 0.009 MHz to 0.15 MHz | 3.7 dB |
| | 0.15 MHz to 30 MHz | 3.3 dB |

Radiated emission

| Measurement distance | Frequency range | | Uncertainty (+/-) |
|----------------------|---------------------|-------------------|-------------------|
| 3 m | 9 kHz to 30 MHz | | 3.3 dB |
| 10 m | | | 3.1 dB |
| 3 m | 30 MHz to 200 MHz | Horizontal | 4.8 dB |
| | | Vertical | 5.0 dB |
| | 200 MHz to 1000 MHz | Horizontal | 5.1 dB |
| | | Vertical | 6.2 dB |
| 10 m | 30 MHz to 200 MHz | Horizontal | 4.8 dB |
| | | Vertical | 4.8 dB |
| | 200 MHz to 1000 MHz | Horizontal | 4.9 dB |
| | | Vertical | 5.0 dB |
| 3 m | 1 GHz to 6 GHz | Test Receiver | 5.0 dB |
| | | Spectrum analyzer | 4.9 dB |
| | 6 GHz to 18 GHz | Test Receiver | 5.3 dB |
| | | Spectrum analyzer | 5.2 dB |
| 1 m | 10 GHz to 26.5 GHz | Spectrum analyzer | 5.5 dB |
| | 26.5 GHz to 40 GHz | Spectrum analyzer | 5.4 dB |
| 0.5 m | 26.5 GHz to 40 GHz | Spectrum analyzer | 5.4 dB |
| 10 m | 1 GHz to 18 GHz | Test Receiver | 5.3 dB |
| >= 0.5 m | 40 GHz to 50 GHz | | 4.2 dB |
| >= 0.5 m | 50 GHz to 75 GHz | | 5.9 dB |
| >= 0.5 m | 75 GHz to 110 GHz | | 5.5 dB |
| >= 3.8 cm | 110 GHz to 170 GHz | | 5.8 dB |
| >= 2.5 cm | 170 GHz to 260 GHz | | 5.0 dB |

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

| Test site | Width x Depth x Height (m) | Size of reference ground plane (m) / horizontal conducting plane | Other rooms | Maximum measurement distance |
|----------------------------|----------------------------|--|------------------------|------------------------------|
| No.1 semi-anechoic chamber | 19.2 x 11.2 x 7.7 | 7.0 x 6.0 | No.1 Power source room | 10 m |
| No.2 semi-anechoic chamber | 7.5 x 5.8 x 5.2 | 4.0 x 4.0 | - | 3 m |
| No.3 semi-anechoic chamber | 12.0 x 8.5 x 5.9 | 6.8 x 5.75 | No.3 Preparation room | 3 m |
| No.3 shielded room | 4.0 x 6.0 x 2.7 | N/A | - | - |
| No.4 semi-anechoic chamber | 12.0 x 8.5 x 5.9 | 6.8 x 5.75 | No.4 Preparation room | 3 m |
| No.4 shielded room | 4.0 x 6.0 x 2.7 | N/A | - | - |
| No.5 semi-anechoic chamber | 6.0 x 6.0 x 3.9 | 6.0 x 6.0 | - | - |
| No.5 measurement room | 6.4 x 6.4 x 3.0 | 6.4 x 6.4 | - | - |
| No.6 shielded room | 4.0 x 4.5 x 2.7 | 4.0 x 4.5 | - | - |
| No.6 measurement room | 4.75 x 5.4 x 3.0 | 4.75 x 4.15 | - | - |
| No.7 shielded room | 4.7 x 7.5 x 2.7 | 4.7 x 7.5 | - | - |
| No.8 measurement room | 3.1 x 5.0 x 2.7 | 3.1 x 5.0 | - | - |
| No.9 measurement room | 8.8 x 4.6 x 2.8 | 2.4 x 2.4 | - | - |
| No.10 shielded room | 3.8 x 2.8 x 2.8 | 3.8 x 2.8 | - | - |
| No.11 measurement room | 4.0 x 3.4 x 2.5 | N/A | - | - |
| No.12 measurement room | 2.6 x 3.4 x 2.5 | N/A | - | - |
| Large Chamber | 16.9 x 22.1 x 10.17 | 16.9 x 22.1 | - | 10 m |
| Small Chamber | 5.3 x 6.69 x 3.59 | 5.3 x 6.69 | - | - |

* Size of vertical conducting plane (for Conducted Emission test): 2.0 m x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, RF Exposure, Test instruments, and Test set up

Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

| Mode | Test Item |
|--|---|
| Test mode (Tx) - Symbol Pattern 1 - Symbol Pattern 2 - Symbol Pattern 3 - Symbol Pattern 4 - Symbol Pattern 5 | Conducted Emission ^{*1)} Duty cycle, Off Time Requirement ^{*2)} 20 dB Bandwidth EIRP(Peak) Spurious Emissions ^{*1)} Frequency Stability |
| *Power of the EUT was set by the software as follows; | |
| Power Setting: 9 Software: Ver214 (Date: 2023.07.10, Storage location: EUT memory) | |
| *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product. | |

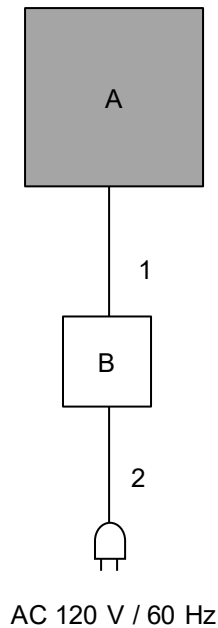
*1) The test was performed with the Symbol Pattern 1 as representative.

Since the Symbol Pattern 1 which has the widest OBW and the highest power was taken as the worst.

*2) The test data of Symbol Pattern 1 was shown as representative since all symbol patterns was the same logic.

4.2 Configuration and peripherals

Conducted Emission test



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

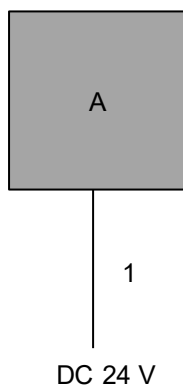
Description of EUT and Support equipment

| No. | Item | Model number | Serial number | Manufacturer | Remarks |
|-----|-----------------|--------------|---------------|---------------------|---------|
| A | Level sensor | FR-S01 | SI38 | Keyence Corporation | EUT |
| B | DC power supply | RPE-4323 | 824B168G2 | RS COMPONENTS LTD | - |

List of cables used

| No. | Name | Length (m) | Shield | | Remarks |
|-----|-------------------|------------|------------|------------|---------|
| | | | Cable | Connector | |
| 1 | DC & Signal Cable | 8.4 | Unshielded | Unshielded | - |
| 2 | AC Cable | 1.9 | Unshielded | Unshielded | - |

Radiated Emission test



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT

| No. | Item | Model number | Serial number | Manufacturer | Remarks |
|-----|--------------|--------------|---------------|---------------------|---------|
| A | Level sensor | FR-S01 | SI38 | Keyence Corporation | EUT |

List of cables used

| No. | Name | Length (m) | Shield | | Remarks |
|-----|-------------------|---------------------|------------|------------|---------|
| | | | Cable | Connector | |
| 1 | DC & Signal Cable | 2.4 *1) 30.0 *2) | Unshielded | Unshielded | - |

*1) Used for other than Spurious Emissions test.

*2) Used for Spurious Emissions test only

SECTION 5: Conducted Emission

Test Procedure and Conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50 ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

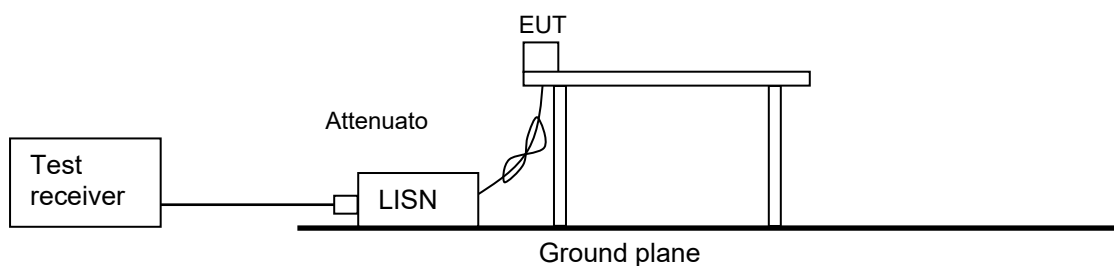
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector : QP and CISPR AV
Measurement Range : 0.15 MHz to 30 MHz
Test Data : APPENDIX
Test Result : Pass

Figure 1: Test Setup



SECTION 6: Radiated Emissions

Test Procedure

[For below 30 MHz]

The EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The loop antenna was fixed height at 1.0 m.

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., 135 deg., and 180 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

[For above 30 MHz, up to 1 GHz]

The EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

[For above 1 GHz, up to 40 GHz]

The EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer.

The test was made with the detector (RBW/VBW) in the following table.

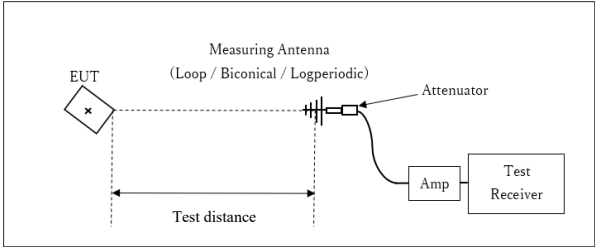
Test Antennas are used as below;

| Frequency | Below 30 MHz | 30 MHz to 200 MHz | 200 MHz to 1 GHz | Above 1 GHz |
|--------------|--------------|-------------------|------------------|-------------|
| Antenna Type | Loop | Biconical | Logperiodic | Horn |

| Frequency | From 9 kHz to 90 kHz and From 110 kHz to 150 kHz | From 90 kHz to 110 kHz | From 150 kHz to 490 kHz | From 490 kHz to 30 MHz | From 30 MHz to 1 GHz | From 1 GHz to 40 GHz | |
|-----------------|--|------------------------|-------------------------|------------------------|----------------------|--------------------------|--------------------------|
| Instrument used | Test Receiver | | | | | Spectrum Analyzer | |
| Detector | PK / AV | QP | PK / AV | QP | QP | PK *a) | AV |
| IF Bandwidth | 200 Hz | 200 Hz | 9 kHz | 9 kHz | 120 kHz | RBW: 1 MHz VBW: 3 MHz | RBW: 1 MHz VBW: 1 / T |

*a) The Spectrum Analyzer was used in 3 dB resolution bandwidth.

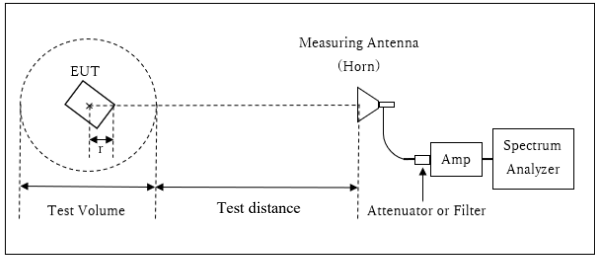
[Test setup]
 Below 1 GHz



Test Distance: 3 m

× : Center of turn table

1 GHz to 10 GHz



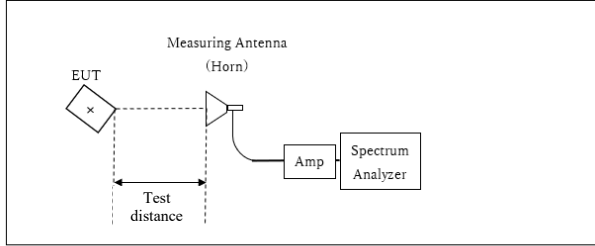
Distance Factor: $20 \times \log(4.0 \text{ m} / 3.0 \text{ m}) = 2.5 \text{ dB}$
 * Test Distance: $(3 + \text{SVSWR Volume}/2) - r = 4.0 \text{ m}$

SVSWR Volume : 2.0 m
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 $r = 0.0 \text{ m}$

*The test was performed with $r = 0.0 \text{ m}$ since EUT is small and it was the rather conservative condition.

r : Radius of an outer periphery of EUT
 × : Center of turn table

10 GHz to 40 GHz

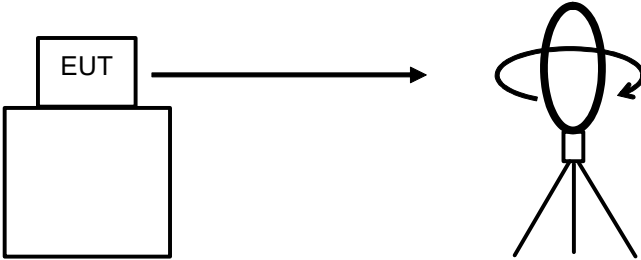


Distance Factor: $20 \times \log(1.0 \text{ m}^* / 3.0 \text{ m}) = -9.5 \text{ dB}$
 *Test Distance: 1 m

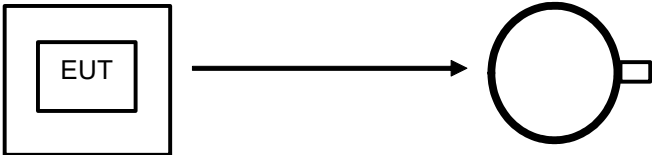
× : Center of turn table

Figure 1: Direction of the Loop Antenna

Side View (Vertical)

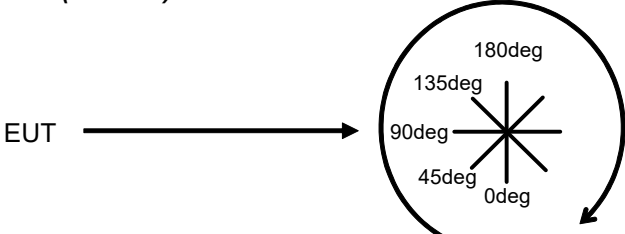


Top View (Horizontal)



Antenna was not rotated.

Top View (Vertical)



Front side: 0 deg.
Forward direction: clockwise

[Above 40 GHz]

The test was performed based on “Procedures for testing millimeter-wave systems” of ANSI C63.10-2013.

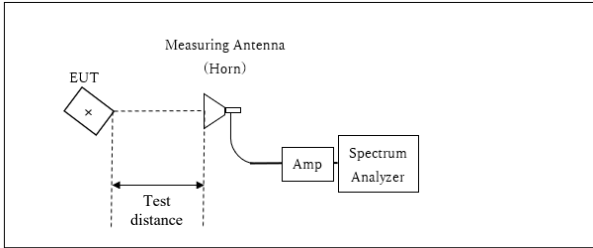
The EUT was placed on a urethane platform, raised 1.5 m above the conducting ground plane. The measurements were performed on handheld method.

Set spectrum analyzer RBW, VBW, span, etc., to the proper values. Note these values. Enable two traces—one set to “clear write,” and the other set to “max hold.” Begin hand-held measurements with the test antenna (horn) at a distance of 1 m from the EUT in a horizontally polarized position. Slowly adjust its position, entirely covering the plane 1 m from the EUT. Observation of the two active traces on the spectrum analyzer will allow refined horn positioning at the point(s) of maximum field intensity. Repeat with the horn in a vertically polarized position. If the emission cannot be detected at 1 m, reduce the RBW to increase system sensitivity. Note the value. If the emission still cannot be detected, move the horn closer to the EUT, noting the distance at which a measurement is made.

Note the maximum level indicated on the spectrum analyzer. Adjust this level, if necessary, by the antenna gain, filter loss, conversion loss of the external mixer and gain of LNA used, at the frequency under investigation. Calculate the field strength of the emission at the measurement distance from the Friis’ transmission equation.

| Frequency | 40 GHz to 50 GHz | 50 GHz to 75 GHz | 75 GHz to 110 GHz | 110 GHz to 200 GHz |
|---|------------------|------------------|-------------------|--------------------|
| Final measurement distance with 1 MHz Peak detector | 1.0 m | 0.75 m | 0.5 m | 0.01 m |

[Test setup]
 40 GHz to 200 GHz



x : Center of turn table

*Test Distance: Refer to the above table.

[About fundamental measurement]

Test Procedure

The test was performed based on “Procedures for testing millimeter-wave systems” of ANSI C63.10-2013.

The peak power were measured with an RF detector that has a detection bandwidth that encompasses the 57-71 GHz band and has a video bandwidth of at least 10 MHz.

The carrier levels were measured in the far field. The distance of the far field was calculated from follow equation.

$$r = \frac{2D^2}{\lambda}$$

where

r is the distance from the radiating element of the EUT to the edge of the far field, in m

D is the largest dimension of both the radiating element and the test antenna (horn), in m

Lambda is the wavelength of the emission under investigation [300/*f* (MHz)], in m

| Frequency [GHz] | Wavelength <i>Lambda</i> [mm] | Maximum Dimention | | | Far Field Boundary <i>r</i> [m] | Tested Distance [m] |
|--------------------|-------------------------------------|-------------------|------------------------|----------------------------|--|---------------------------|
| | | EUT [m] | Test Antenna [m] | Maximum <i>D</i> [m] | | |
| 63 | 4.8 | 0.01940 | 0.03759 | 0.03759 | 0.594 | 0.65 |

The test was performed based on stages 1-4 following;

Stage 1:

Connect the measurement antenna for the fundamental frequency band to the mm-wave RF detector.

Place the measurement antenna at a test distance that is in the far-field of the measurement antenna.

Place the measurement antenna in the main beam of the EUT then maximize the fundamental emission.

The maximum direction was searched under carefully since beam-widths are extremely narrow.

Record the peak voltage from DSO as DSO Reading.

Stage 2:

Disconnect the measurement antenna from the RF input port of the instrumentation system.

Connect a mm-wave source to the RF input port of the instrumentation system via a waveguide variable attenuator.

The mm-wave source shall be unmodulated.

Adjust the frequency of the mm-wave source to the center of the frequency range occupied by the transmitter.

Adjust the amplitude of the mm-wave source and/or the variable attenuator such that the DSO indicates a voltage equal to the peak voltage recorded in Stage 1.

The output level of mm-wave source at this time is recorded as SG Reading.

Stage 3:

Disconnect the waveguide variable attenuator from the RF input port of the instrumentation system.

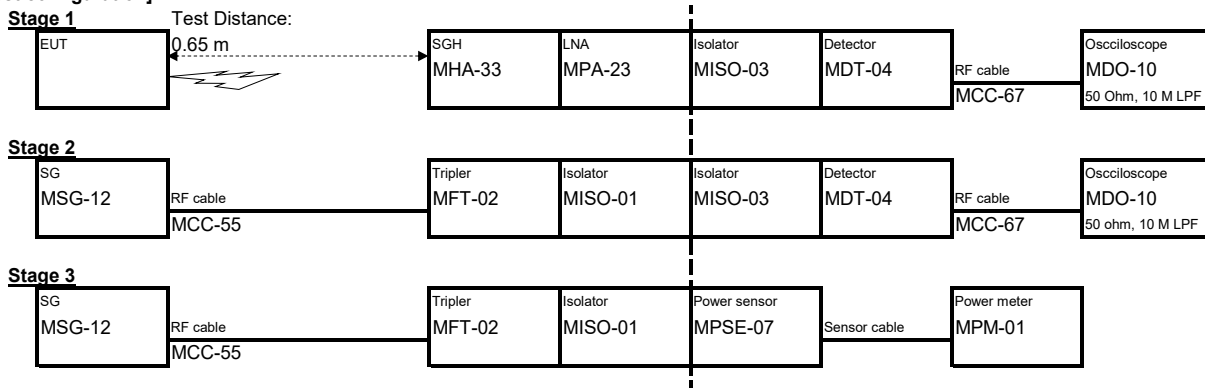
Without changing any settings, connect the waveguide variable attenuator to a wideband mm-wave power meter with a thermocouple detector or equivalent.

Measure the power and record it as PM reading.

Stage 4:

Correct the peak substitution power at the input to the measurement instrument, as recorded in Stage 3, for any external gain and/or attenuation between the measurement antenna and the measurement instrument that was not included in the substitution power measurement.

[Test configuration]



In order to maximize the carrier level, the EUT, which has a horizontally polarized antenna, and the polarization plane of the measurement antenna were aligned for the test.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz to 200 GHz
 Test data : APPENDIX
 Test result : Pass

SECTION 7: Frequency Stability

Test Procedure

The block downconverter was placed in side of the temperature chamber's drain hole.

The power supply was set to nominal operating voltage (100 %), and the spectrum mask was measured at 20 deg. C. After that, EUT power supply was varied between 85 % and 115 % of nominal voltage and the frequency excursion of the EUT emission mask was recorded.

The EUT operating temperature was raised to 50 deg. C., and the frequency excursion of the EUT emission mask was recorded. Measurements were repeated at each 10 deg. C. decrement down to -20 deg. C.

In addition, additional tests were performed with some temperatures according to the customer's request.

Both lower and upper frequencies of the -20 dB Bandwidth were recorded.

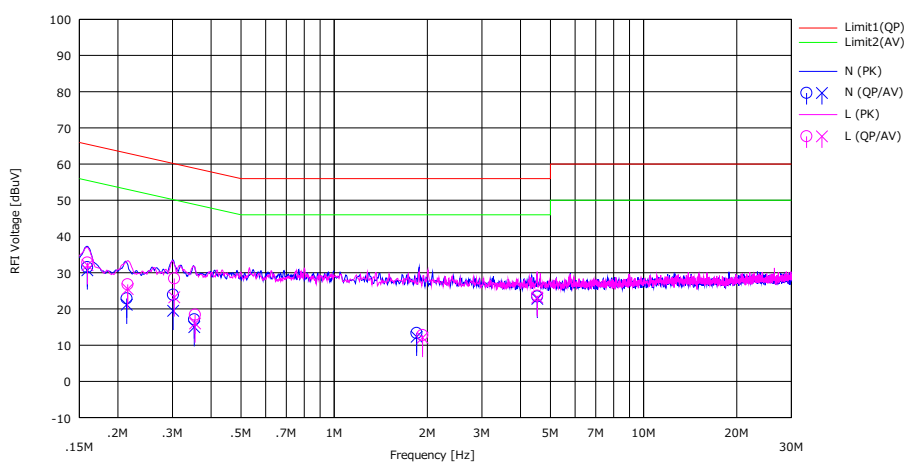
Test data : **APPENDIX**
Test result : **Pass**

APPENDIX 1: Test data

Conducted Emission

| | |
|------------------------|---------------------|
| Test place | Ise EMC Lab. |
| Semi Anechoic Chamber | No. 4 |
| Date | July 24, 2023 |
| Temperature / Humidity | 23 deg. C / 54 % RH |
| Engineer | Sayaka Hara |
| Mode | Tx Symbol Pattern 1 |

Limit : FCC_Part 15 Subpart C(15.207)



| No. | Freq. [MHz] | Reading | | USN | LOSS | Results | | Limit | | Margin | | Phase | Comment |
|-----|----------------|----------------|----------------|------|-------|----------------|----------------|--------------|--------------|--------|-------|-------|---------|
| | | (QP) [dBuV] | (AV) [dBuV] | | | (QP) [dBuV] | (AV) [dBuV] | (QP) [dB] | (AV) [dB] | | | | |
| 1 | 0.15935 | 18.30 | 17.50 | 0.05 | 13.13 | 31.48 | 30.68 | 65.50 | 55.50 | 34.02 | 24.82 | N | |
| 2 | 0.21350 | 9.70 | 8.00 | 0.04 | 13.13 | 22.87 | 21.17 | 63.07 | 53.07 | 40.20 | 31.90 | N | |
| 3 | 0.30150 | 10.70 | 6.30 | 0.04 | 13.15 | 23.89 | 19.49 | 60.20 | 50.20 | 36.31 | 30.71 | N | |
| 4 | 0.35300 | 3.90 | 1.80 | 0.04 | 13.16 | 17.10 | 15.00 | 58.89 | 48.89 | 41.79 | 33.89 | N | |
| 5 | 1.84684 | 0.00 | -1.00 | 0.06 | 13.27 | 13.33 | 12.33 | 56.00 | 46.00 | 42.67 | 33.67 | N | |
| 6 | 4.53220 | 9.90 | 9.30 | 0.11 | 13.41 | 23.42 | 22.82 | 56.00 | 46.00 | 32.58 | 23.18 | N | |
| 7 | 0.15943 | 19.60 | 18.90 | 0.05 | 13.13 | 32.78 | 32.08 | 65.49 | 55.49 | 32.71 | 23.41 | L | |
| 8 | 0.21491 | 13.60 | 12.30 | 0.04 | 13.13 | 26.77 | 25.47 | 63.01 | 53.01 | 36.24 | 27.54 | L | |
| 9 | 0.30411 | 15.20 | 10.00 | 0.05 | 13.15 | 28.40 | 23.20 | 60.13 | 50.13 | 31.73 | 26.93 | L | |
| 10 | 0.35510 | 6.20 | 2.80 | 0.05 | 13.16 | 18.41 | 16.01 | 58.84 | 48.84 | 40.43 | 32.83 | L | |
| 11 | 1.92896 | -0.60 | -1.30 | 0.07 | 13.28 | 12.75 | 12.05 | 56.00 | 46.00 | 43.25 | 33.95 | L | |
| 12 | 4.53050 | 10.10 | 9.60 | 0.12 | 13.41 | 23.63 | 23.13 | 56.00 | 46.00 | 32.37 | 22.87 | L | |

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + C.F (LISN + CABLE + ATT)
Except for the above table: adequate margin data below the limits.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

Duty Cycle, Off Time Requirement

| | |
|------------------------|---------------------|
| Test place | Ise EMC Lab. |
| Semi Anechoic Chamber | No. 4 |
| Date | July 11, 2023 |
| Temperature / Humidity | 21 deg. C / 55 % RH |
| Engineer | Junki Nagatomi |
| Mode | Tx Symbol Pattern 1 |

| Measured/Declared | Tx ON+Tx OFF Time [ms] | Tx ON Time [ms] | Tx OFF Time [ms] | Duty Result [%] | Duty Factor [dB] |
|-------------------|---------------------------|--------------------|---------------------|--------------------|---------------------|
| Measured | 140.000 | 2.166 | 137.833 | 1.55 | -18.10 |
| Declared * | 139.998 | 2.048 | 137.950 | 1.46 | -18.35 |

| Measured/Declared | The ratio of Tx OFF Time [%] | Regulation Time [ms] | Tx OFF Time within Regulation Time Limit [ms] | The ratio of Tx OFF Time Limit [%] | Result |
|-------------------|---------------------------------|-------------------------|--|---------------------------------------|--------|
| Measured | 98.45 | 33.00 | 25.50 | ≥ 77.27 | Pass |
| Declared * | 98.54 | - | - | - | - |

Calculating formula:

$$\text{Tx OFF Time} = \text{Tx ON} + \text{Tx OFF Time} - \text{Tx ON Time}$$

$$\text{Duty} = (\text{Tx ON Time} / \text{Tx ON} + \text{Tx OFF Time}) * 100$$

$$\text{Duty factor} = 10 * \log (\text{Tx ON} + \text{Tx OFF Time} / \text{Tx ON Time})$$

$$\text{The ratio of Tx OFF Time} = (\text{Tx OFF Time} / \text{Tx ON} + \text{Tx OFF Time}) * 100$$

* See the application document.



20 dB Bandwidth

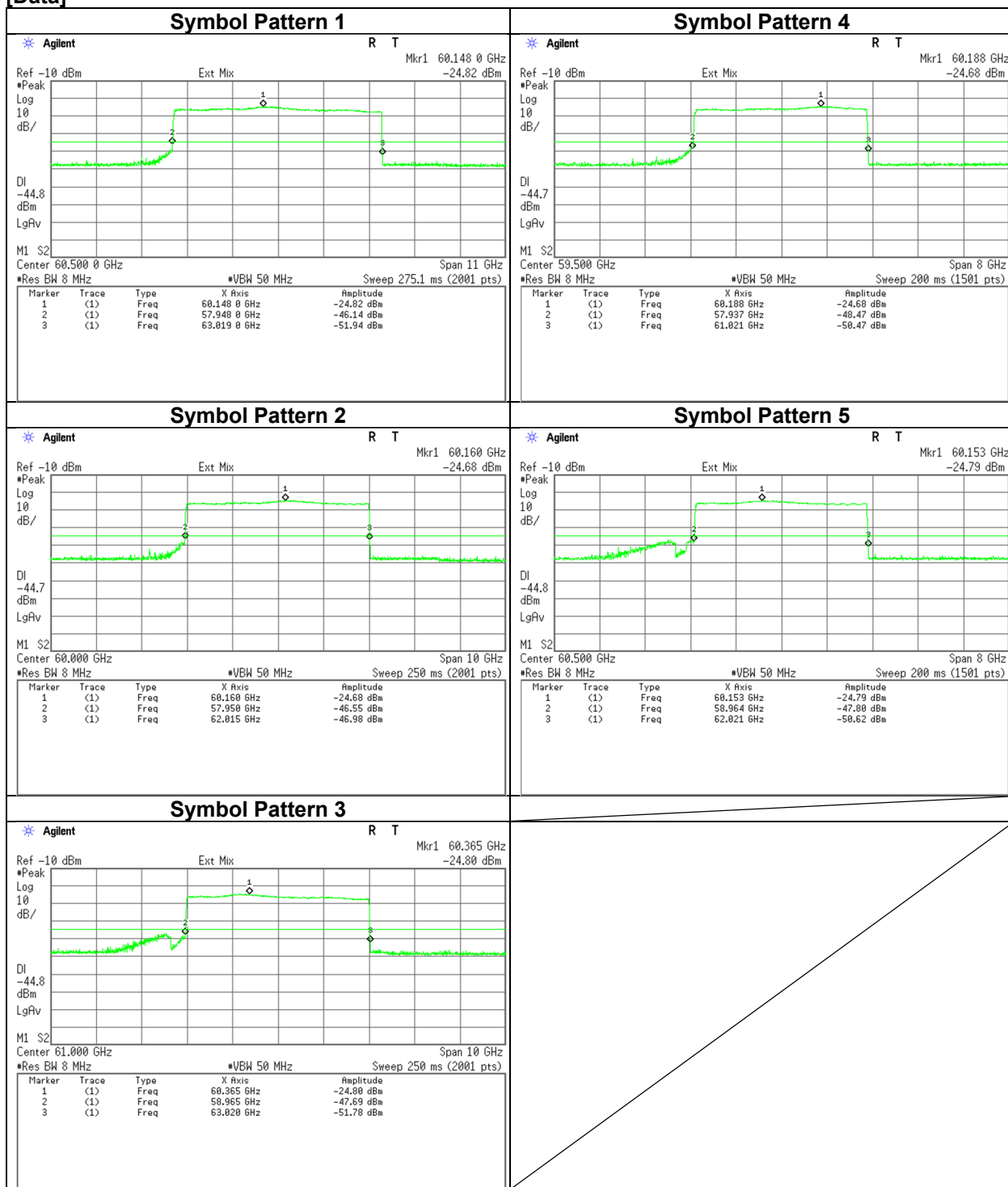
| | |
|------------------------|---------------------|
| Test place | Ise EMC Lab. |
| Semi Anechoic Chamber | No. 4 |
| Date | July 13, 2023 |
| Temperature / Humidity | 22 deg. C / 66 % RH |
| Engineer | Junki Nagatomi |
| Mode | Tx |

| Symbol Pattern | Center Frequency [GHz] | Measured -20 dBc Frequency | | 20 dB bandwidth [MHz] | Lower Limit [GHz] | Upper Limit [GHz] | Result |
|----------------|------------------------|----------------------------|--------------------|-----------------------|-------------------|-------------------|--------|
| | | Lower Result [GHz] | Upper Result [GHz] | | | | |
| 1 | 60.5 | 57.9480 | 63.0190 | 5071.0 | 57 | 64 | Pass |
| 2 | 60.0 | 57.9500 | 62.0150 | 4065.0 | | | Pass |
| 3 | 61.0 | 58.9650 | 63.0200 | 4055.0 | | | Pass |
| 4 | 59.5 | 57.9370 | 61.0210 | 3084.0 | | | Pass |
| 5 | 60.5 | 58.9640 | 62.0210 | 3057.0 | | | Pass |

Calculating formula:

$$20 \text{ dB bandwidth} = (\text{Measured -20 dBc Frequency Upper Result}) - (\text{Measured -20 dBc Frequency Lower Result})$$

[Data]



The measurement was performed with Peak detector and Max Hold since the duty cycle was not 100 %.

EIRP(Peak)

| | | |
|------------------------|---------------------|---------------------|
| Test place | Ise EMC Lab. | |
| Semi Anechoic Chamber | No. 4 | No. 4 |
| Date | July 11, 2023 | July 13, 2023 |
| Temperature / Humidity | 21 deg. C / 55 % RH | 21 deg. C / 49 % RH |
| Engineer | Junki Nagatomi | Sayaka Hara |
| Mode | Tx | |

| Symbol Pattern | Center Frequency [GHz] | Stage 1 | Stage 2 | Stage 3 | Stage 4 | Rx Ant. Gain [dBi] | Tested Distance [m] | FSL [dB] | EIRP (Peak) | | | | |
|----------------|------------------------|-------------------------|-------------------------|-------------------|---------------|--------------------|---------------------|----------|-------------|------|-------|-------|-------------|
| | | DSO Reading (Peak) [mV] | S/G Setting Power [dBm] | P/M Reading [dBm] | LNA Gain [dB] | | | | Result | | Limit | | Margin [dB] |
| | | | | | | | | | [dBm] | [mW] | [dBm] | [mW] | |
| 1 | 60.50 | 2.91 | 9.31 | -12.11 | 25.20 | 23.74 | 0.65 | 64.34 | 3.29 | 2.14 | 14 | 25.12 | 10.71 |
| 2 | 60.00 | 2.84 | 9.23 | -12.23 | 25.37 | 23.67 | 0.65 | 64.26 | 3.00 | 2.00 | 14 | 25.12 | 11.00 |
| 3 | 61.00 | 2.84 | 9.65 | -12.90 | 25.03 | 23.80 | 0.65 | 64.41 | 2.68 | 1.86 | 14 | 25.12 | 11.32 |
| 4 | 59.50 | 2.91 | 9.42 | -12.13 | 25.45 | 23.70 | 0.65 | 64.19 | 2.92 | 1.96 | 14 | 25.12 | 11.08 |
| 5 | 60.50 | 2.84 | 9.27 | -12.47 | 25.20 | 23.74 | 0.65 | 64.34 | 2.93 | 1.97 | 14 | 25.12 | 11.07 |

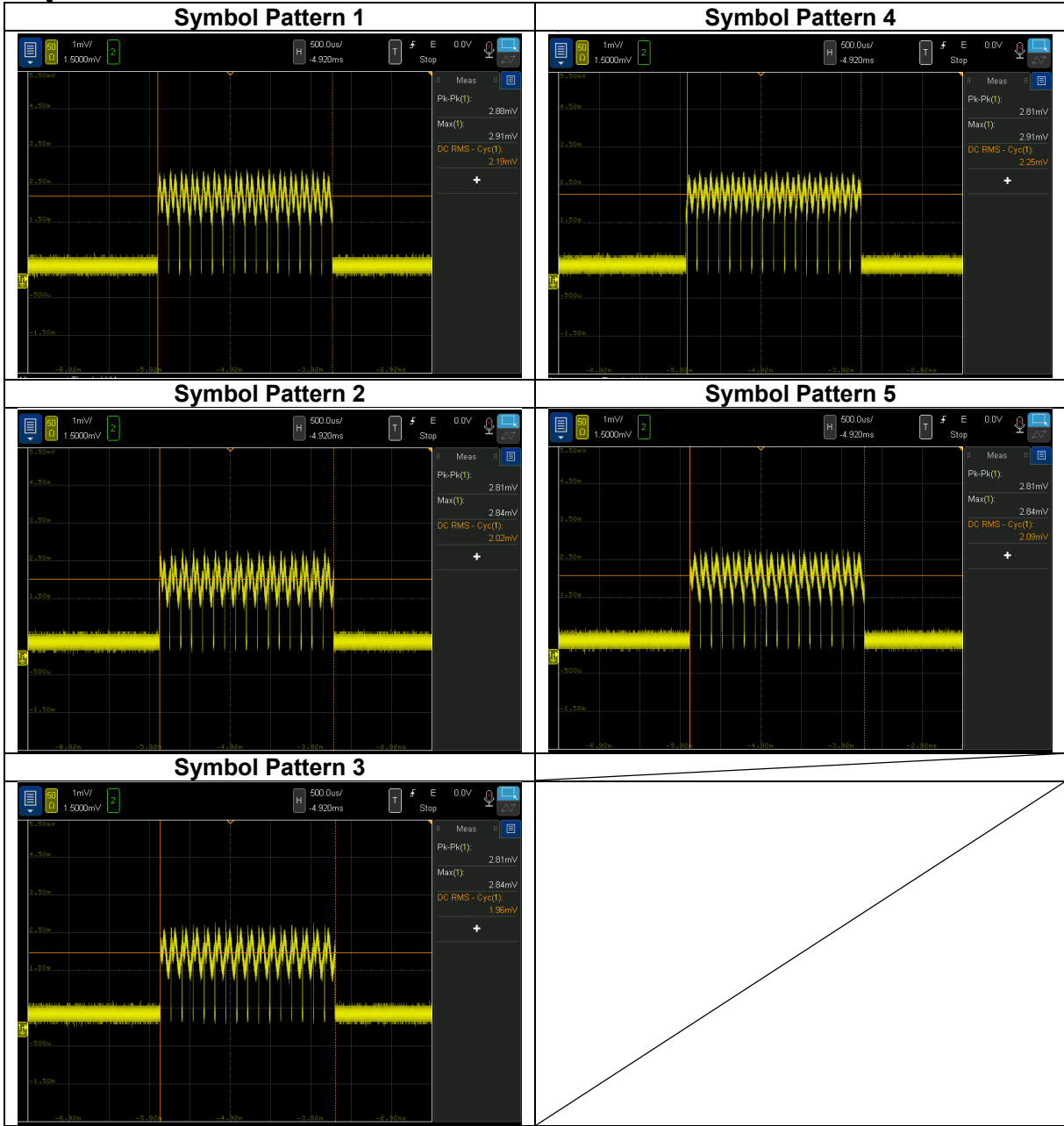
Calculating formula:

FSL (Free Space path Loss) = $10 * \log_{10}((4 * \pi * \text{Tested Distance} / \text{Lambda})^2)$

EIRP (Peak) = P/M Reading - Rx Ant. Gain - LNA Gain + FSL

These calculation results are same as results which were calculated with formulas described in the Section 9 of ANSI C63.10-2013.

[Data]



Spurious Emissions (Below 40 GHz)

| | | | | | | |
|------------------------|---------------------|----------------------|----------------------|----------------------|---------------------|---------------------|
| Test place | Ise EMC Lab. | | | | | |
| Semi Anechoic Chamber | No. 3 | No. 4 | No. 3 | No. 4 | No. 4 | No. 4 |
| Date | July 10, 2023 | July 27, 2023 | July 13, 2023 | July 18, 2023 | July 18, 2023 | July 19, 2023 |
| Temperature / Humidity | 24 deg. C / 49 % RH | 24 deg. C / 48 % RH | 23 deg. C / 56 % RH | 23 deg. C / 42 % RH | 23 deg. C / 42 % RH | 22 deg. C / 54 % RH |
| Engineer | Sayaka Hara | Sayaka Hara | Junki Nagatomi | Junki Nagatomi | Sayaka Hara | Yuichiro Yamazaki |
| | (9 kHz to 30 MHz) | (26.5 GHz to 40 GHz) | (30 MHz to 1000 MHz) | (18 GHz to 26.5 GHz) | (10 GHz to 18 GHz) | (1 GHz to 10 GHz) |
| Mode | Tx Symbol Pattern 1 | | | | | |

| Polarity | Frequency | Reading (QP / PK) | Reading (AV) | Ant. Factor | Loss | Gain | Result (QP / PK) | Result (AV) | Limit (QP / PK) | Limit (AV) | Margin (QP / PK) | Margin (AV) | Remark |
|-------------|-----------|-------------------|--------------|-------------|------|------|------------------|-------------|-----------------|------------|------------------|-------------|--------|
| [Hori/Vert] | [MHz] | [dBuV] | [dBuV] | [dB/m] | [dB] | [dB] | [dBuV/m] | [dBuV/m] | [dBuV/m] | [dBuV/m] | [dB] | [dB] | |
| Hori. | 55.1 | 22.6 | - | 9.4 | 7.5 | 32.2 | 7.3 | - | 40.0 | - | 32.7 | - | |
| Hori. | 312.0 | 31.5 | - | 14.0 | 10.1 | 32.0 | 23.6 | - | 46.0 | - | 22.4 | - | |
| Hori. | 360.0 | 30.9 | - | 15.1 | 10.5 | 32.0 | 24.5 | - | 46.0 | - | 21.5 | - | |
| Hori. | 408.0 | 32.4 | - | 16.1 | 10.8 | 32.0 | 27.4 | - | 46.0 | - | 18.7 | - | |
| Hori. | 456.0 | 33.1 | - | 16.7 | 11.1 | 32.0 | 29.0 | - | 46.0 | - | 17.0 | - | |
| Hori. | 552.0 | 30.2 | - | 17.9 | 11.7 | 32.0 | 27.9 | - | 46.0 | - | 18.1 | - | |
| Vert. | 55.1 | 29.3 | - | 9.4 | 7.5 | 32.2 | 14.0 | - | 40.0 | - | 26.0 | - | |
| Vert. | 312.0 | 28.1 | - | 14.0 | 10.1 | 32.0 | 20.2 | - | 46.0 | - | 25.8 | - | |
| Vert. | 360.0 | 36.3 | - | 15.1 | 10.5 | 32.0 | 29.9 | - | 46.0 | - | 16.1 | - | |
| Vert. | 408.0 | 35.6 | - | 16.1 | 10.8 | 32.0 | 30.5 | - | 46.0 | - | 15.5 | - | |
| Vert. | 456.0 | 34.4 | - | 16.7 | 11.1 | 32.0 | 30.3 | - | 46.0 | - | 15.8 | - | |
| Vert. | 552.0 | 32.7 | - | 17.9 | 11.7 | 32.0 | 30.4 | - | 46.0 | - | 15.6 | - | |

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Result (AV)= Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

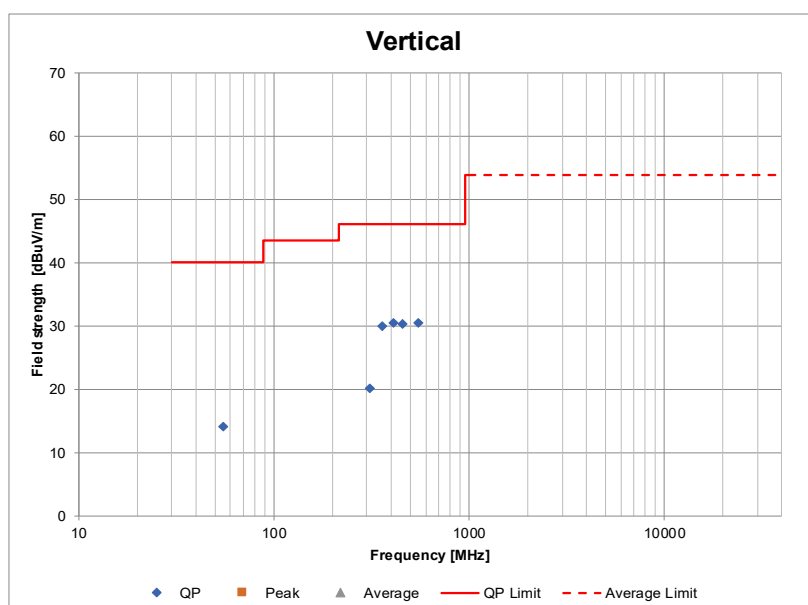
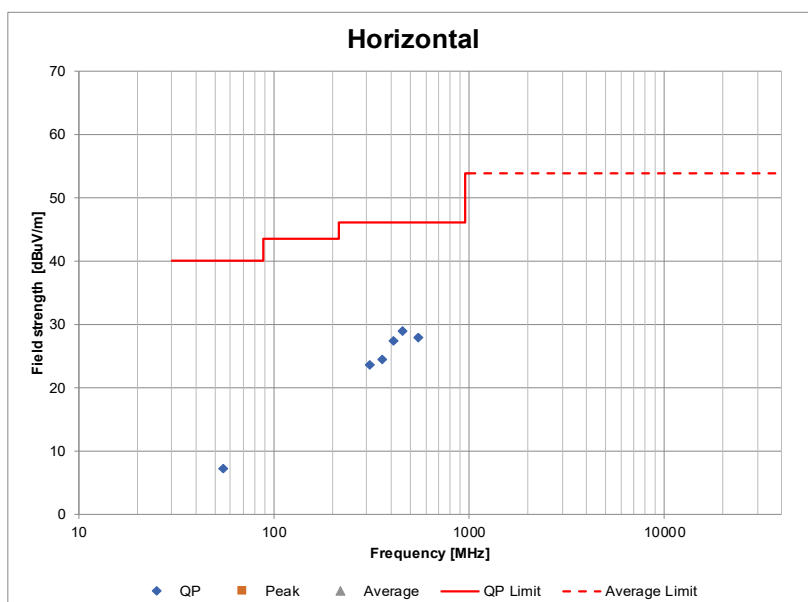
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

Distance factor: 1 GHz - 10 GHz $20\log(4.0\text{ m} / 3.0\text{ m}) = 2.5\text{ dB}$
 10 GHz - 40 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

Spurious Emissions
(Below 40 GHz)
(Plot data, Worst case)

| | | | | | | |
|------------------------|---------------------|----------------------|----------------------|----------------------|---------------------|---------------------|
| Test place | Ise EMC Lab. | | | | | |
| Semi Anechoic Chamber | No. 3 | No. 4 | No. 3 | No. 4 | No. 4 | No. 4 |
| Date | July 10, 2023 | July 27, 2023 | July 13, 2023 | July 18, 2023 | July 18, 2023 | July 19, 2023 |
| Temperature / Humidity | 24 deg. C / 49 % RH | 24 deg. C / 48 % RH | 23 deg. C / 56 % RH | 23 deg. C / 42 % RH | 23 deg. C / 42 % RH | 22 deg. C / 54 % RH |
| Engineer | Sayaka Hara | Sayaka Hara | Junki Nagatomi | Junki Nagatomi | Sayaka Hara | Yuichiro Yamazaki |
| | (9 kHz to 30 MHz) | (26.5 GHz to 40 GHz) | (30 MHz to 1000 MHz) | (18 GHz to 26.5 GHz) | (10 GHz to 18 GHz) | (1 to 10 GHz) |
| Mode | Tx Symbol Pattern 1 | | | | | |



Spurious Emissions (Above 40 GHz)

| | | | | |
|------------------------|----------------------|---------------------|---------------------|----------------------|
| Test place | Ise EMC Lab. | | | |
| Semi Anechoic Chamber | No. 4 | No. 4 | No. 4 | No. 4 |
| Date | July 14, 2023 | July 18, 2023 | July 18, 2023 | July 19, 2023 |
| Temperature / Humidity | 20 deg. C / 50 % RH | 23 deg. C / 42 % RH | 23 deg. C / 42 % RH | 23 deg. C / 64 % RH |
| Engineer | Sayaka Hara | Junki Nagatomi | Sayaka Hara | Sayaka Hara |
| | (110 GHz to 170 GHz) | (40 GHz to 50 GHz) | (50 GHz to 110 GHz) | (170 GHz to 200 GHz) |
| Mode | Tx Symbol Pattern 1 | | | |

| Freq. [GHz] | Reading (Peak) [dBm] | Rx Ant. Gain [dBi] | Filter Loss [dB] | LNA Gain [dB] | Mixer Conv. Loss [dB] | IF Amp. Gain [dB] | IF Cable Loss [dB] | Test Distance D [m] | FSL [dB] | EIRP [dBm] | EIRP [mW] | Power density Result at 3 m (Peak) [pW/cm ²] | Limit Average [pW/cm ²] | Margin Average [dB] | Remarks |
|-------------|----------------------|--------------------|------------------|---------------|-----------------------|-------------------|--------------------|---------------------|----------|------------|-----------|--|-------------------------------------|---------------------|---------|
| 44.501 | -54.46 | 21.70 | 0.00 | 31.85 | 0.00 | 0.00 | 7.99 | 1.00 | 65.41 | -34.61 | 0.000346 | 0.31 | 90 | 24.68 | NS |
| 49.855 | -53.41 | 22.58 | 0.00 | 31.87 | 0.00 | 0.00 | 8.60 | 1.00 | 66.40 | -32.87 | 0.000517 | 0.46 | 90 | 22.94 | NS |
| 52.626 | -67.50 | 23.07 | 0.00 | 27.10 | 46.28 | 32.04 | 0.11 | 0.75 | 64.37 | -38.95 | 0.000127 | 0.11 | 90 | 29.02 | NS |
| 73.956 | -68.13 | 24.47 | 0.00 | 21.05 | 51.52 | 32.04 | 0.11 | 0.75 | 67.32 | -26.74 | 0.002120 | 1.87 | 90 | 16.81 | NS |
| 81.774 | -57.13 | 23.47 | 0.40 | 34.63 | 40.95 | 32.04 | 0.11 | 0.50 | 64.67 | -41.14 | 0.000077 | 0.07 | 90 | 31.21 | NS |
| 88.509 | -57.09 | 23.88 | 0.43 | 33.11 | 42.22 | 32.04 | 0.11 | 0.50 | 65.36 | -38.00 | 0.000159 | 0.14 | 90 | 28.07 | NS |
| 95.099 | -56.52 | 24.26 | 0.32 | 33.77 | 42.92 | 32.04 | 0.11 | 0.50 | 65.98 | -37.25 | 0.000188 | 0.17 | 90 | 27.33 | NS |
| 101.207 | -55.70 | 24.53 | 0.51 | 33.18 | 43.85 | 32.04 | 0.11 | 0.50 | 66.53 | -34.45 | 0.000359 | 0.32 | 90 | 24.53 | NS |
| 108.580 | -56.27 | 24.81 | 1.05 | 21.89 | 44.24 | 32.04 | 0.11 | 0.50 | 67.14 | -22.48 | 0.005652 | 5.00 | 90 | 12.55 | NS |
| 116.619 | -82.06 | 22.52 | 0.00 | 17.46 | 55.69 | 0.00 | 0.00 | 0.01 | 33.78 | -32.57 | 0.000553 | 0.49 | 90 | 22.65 | NS |
| 120.408 | -84.84 | 22.66 | 0.00 | 18.98 | 51.79 | 0.00 | 0.00 | 0.01 | 34.05 | -40.63 | 0.000086 | 0.08 | 90 | 30.71 | NS |
| 122.131 | -83.45 | 22.71 | 0.00 | 19.77 | 49.80 | 0.00 | 0.00 | 0.01 | 34.18 | -41.95 | 0.000064 | 0.06 | 90 | 32.03 | NS |
| 129.108 | -83.95 | 22.92 | 0.00 | 20.54 | 52.13 | 0.00 | 0.00 | 0.01 | 34.66 | -40.62 | 0.000087 | 0.08 | 90 | 30.70 | NS |
| 131.321 | -84.48 | 22.98 | 0.00 | 20.04 | 53.25 | 0.00 | 0.00 | 0.01 | 34.81 | -39.44 | 0.000114 | 0.10 | 90 | 29.52 | NS |
| 140.282 | -84.83 | 23.19 | 0.00 | 18.78 | 54.25 | 0.00 | 0.00 | 0.01 | 35.38 | -37.17 | 0.000192 | 0.17 | 90 | 27.25 | NS |
| 152.575 | -86.90 | 23.35 | 0.00 | 17.88 | 56.53 | 0.00 | 0.00 | 0.01 | 36.11 | -35.49 | 0.000283 | 0.25 | 90 | 25.56 | NS |
| 157.136 | -87.24 | 23.38 | 0.00 | 17.38 | 58.68 | 0.00 | 0.00 | 0.01 | 36.37 | -32.95 | 0.000507 | 0.45 | 90 | 23.03 | NS |
| 165.000 | -87.64 | 23.41 | 0.00 | 14.61 | 60.27 | 0.00 | 0.00 | 0.01 | 36.79 | -28.60 | 0.001381 | 1.22 | 90 | 18.68 | NS |
| 173.259 | -84.58 | 22.47 | 0.00 | 0.00 | 56.55 | 0.00 | 0.00 | 0.01 | 37.22 | -13.29 | 0.046921 | 41.49 | 90 | 3.36 | NS |
| 178.824 | -86.57 | 22.61 | 0.00 | 0.00 | 58.04 | 0.00 | 0.00 | 0.01 | 37.49 | -13.65 | 0.043125 | 38.13 | 90 | 3.73 | NS |
| 187.083 | -86.52 | 22.78 | 0.00 | 0.00 | 55.97 | 0.00 | 0.00 | 0.01 | 37.88 | -15.44 | 0.028559 | 25.25 | 90 | 5.52 | NS |
| 199.828 | -86.44 | 23.01 | 0.00 | 0.00 | 55.81 | 0.00 | 0.00 | 0.01 | 38.45 | -15.19 | 0.030303 | 26.79 | 90 | 5.26 | NS |

Calculation:

$$FSL \text{ (Free Space path Loss)} = 10 * \log ((4 * \pi * D / \lambda)^2)$$

$$EIRP = \text{Reading} - \text{Rx Ant. gain} + \text{Filter loss} - \text{LNA gain} + \text{Mixer conversion loss} - \text{IF Amp. gain} + \text{IF Cable loss} + \text{FSL}$$

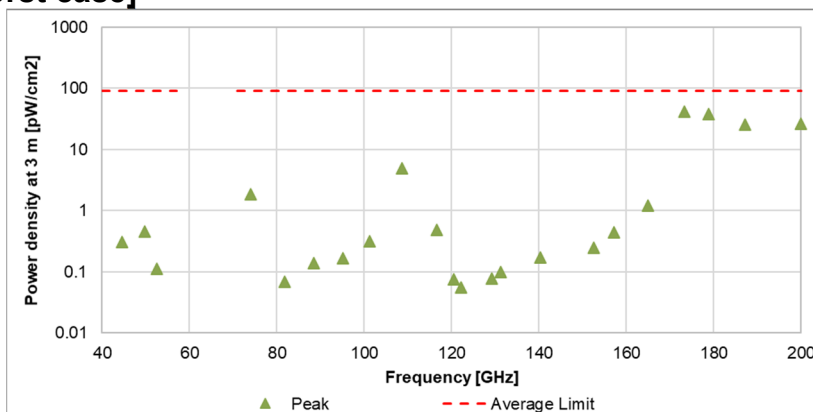
$$\text{Power density Result at 3 m} = EIRP / (4 * \pi * 300^2)$$

These calculation results are same as results which were calculated with formulas described in the Section 9 of ANSI C63.10-2013.

- The equipment were not used for factor 0 dB of the data sheets.
- The IF Cable loss is included in Mixer loss, so the factor of data sheet were 0 dB.

NS: No signal detected.

[Plot data, Worst case]



*The peak result is less than the average limit.